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In situ Nafion-nanofilm oriented (002) Zn electrodeposition
for long-term zinc-ion batteries

Our study introduces perfluoropolymer (Nafion) into aqueous electrolyte to activate a thermodynamically ultrastable Zn/electrolyte interface. This ultrathin artificial solid electrolyte interface with zincophilic -SO_3^- groups guides the directional Zn^{2+} electrodeposition along the (002) crystal surface even at high current density, yielding a dendrite-free Zn anode for propelling high-performance zinc-ion batteries.

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In situ Nafion-nanofilm oriented (002) Zn electrodeposition for long-term zinc-ion batteries†

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Dendrite growth and parasitic reactions of a Zn metal anode in aqueous media hinder the development of up-and-coming Zn-ion batteries. Optimizing the crystal growth after Zn nucleation is promising to enable stable cyclic performance of the anode, but directly regulating specific crystal plane growth for homogenized Zn electrodeposition remains highly challenging. Herein, a perfluoropolymer (Nafion) is introduced into an aqueous electrolyte to activate a thermodynamically ultrastable Zn/electrolyte interface for long-term Zn-ion batteries. The low adsorption energy (−2.09 eV) of Nafion molecules on Zn metal ensures the *in situ* formation of a Nafion-nanofilm during the first charge process. This ultrathin artificial solid electrolyte interface with zincophilic $-\text{SO}_3^-$ groups guides the directional Zn^{2+} electrodeposition along the (002) crystal surface even at high current density, yielding a dendrite-free Zn anode. The synergic Zn/electrolyte interphase electrochemistry contributes an average coulombic efficiency of 99.71% after 4500 cycles for

accompanied by decreasing the surface nucleation energy for achieving stable Zn electrodeposition to inhibit the HER is expected to boost the anode reversibility and long-term ZIBs, yet not reported.

In this work, we introduce perfluoropolymer (Nafion) molecules to construct an anode micro-electric field and activate a thermodynamically ultrastable zinc anode/electrolyte interface for propelling high-performance ZMBs. The spontaneous adsorption of Nafion (NAF) molecules on the Zn anode ensures the *in situ* generation of zincophilic NAF-film, which regulates the directional and dendrite-free deposition of solvated Zn^{2+} ions, significantly improving the plating/stripping efficiency of the Zn anode. Therefore, Zn||Zn cells using a $\text{Zn}(\text{OTF})_2$ -NAF ($\text{OTF}^- = \text{CF}_3\text{SO}_3^-$) electrolyte can cycle over 5000 h, and Zn||Cu cells achieve an average CE of 99.71% after 4500 cycles at 5 mA cm^{-2} . Significantly, Zn|| MnO_2 cells exhibit remarkable cyclic stability over 3000 cycles. Even at -40°C , the reversible plating/stripping of Zn||Zn cells can work over 1200 h. This work offers a design avenue of dendrite-free Zn deposition for ultrastable ZMBs.

Results and discussion

First-principles calculations and systemic experiments were performed to study the Zn^{2+} transport mechanisms in $\text{Zn}(\text{OTF})_2$ - H_2O and $\text{Zn}(\text{OTF})_2$ -NAF electrolytes.^{36–39} For the $\text{Zn}(\text{OTF})_2$ - H_2O electrolyte interface (Fig. 1a), when the solvated Zn^{2+} ions migrate to the anode/electrolyte interface, the inhomogeneous Zn^{2+} plating and $\text{Zn}(\text{OTF})_2$ decomposition result in potential differentiation at the Zn anode, further leading to the fracturing of the SEI and the generation of H_2 (Fig. S1†). In comparison, NAF molecules show a high binding energy with Zn metal (Fig. S2–S4 and Table S1†), which indicates their great predilection to form a NAF-n

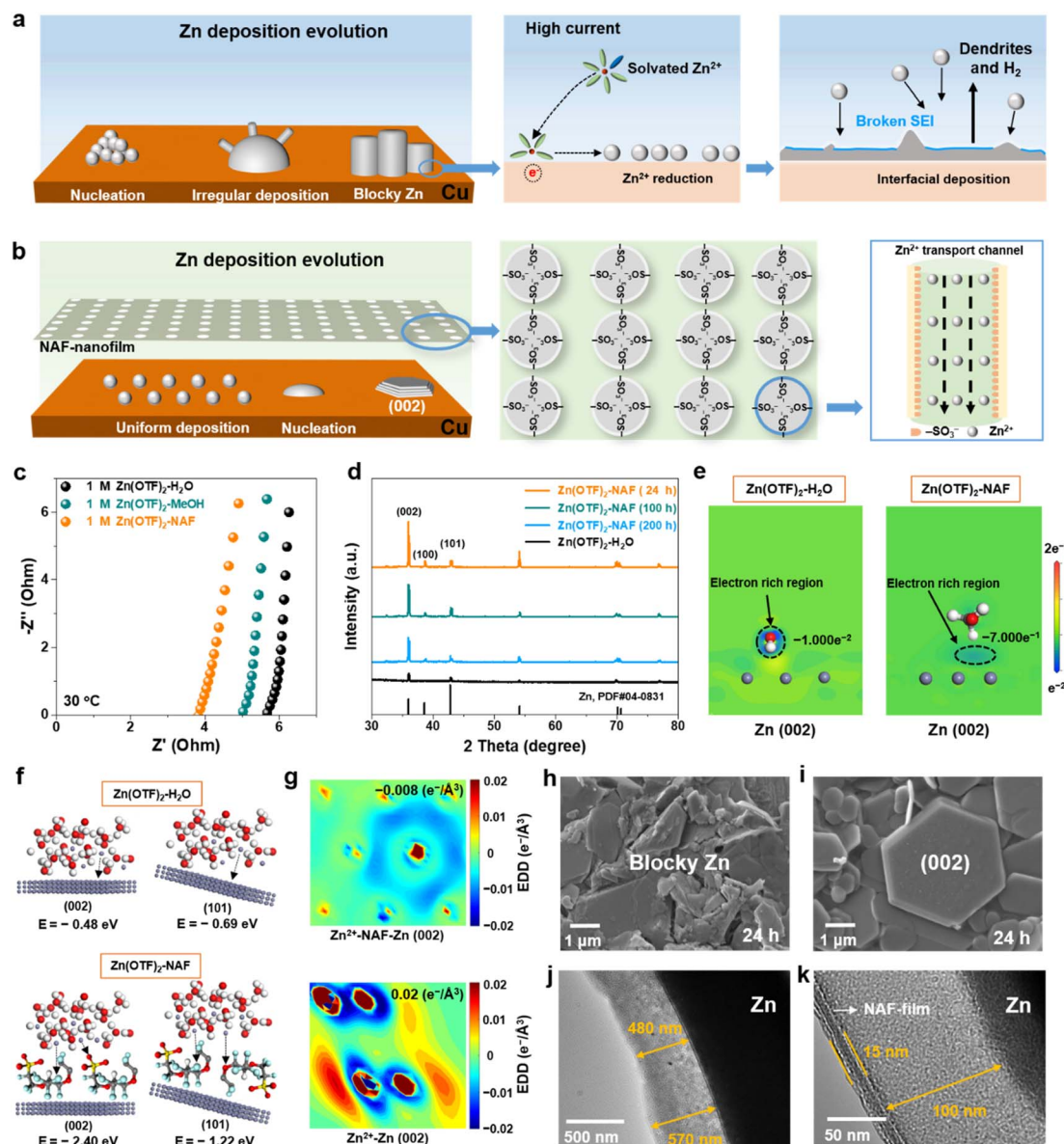


Fig. 1 Schematic diagrams of Zn^{2+} deposition in (a) $\text{Zn}(\text{OTF})_2\text{-H}_2\text{O}$ and (b) $\text{Zn}(\text{OTF})_2\text{-NAF}$ electrolytes. (c) Ionic conductivities of various electrolytes. (d) XRD patterns after Zn^{2+} plating/stripping with different electrolytes. (e) Charge distribution of the Zn anode after Zn^{2+} plating on the (002) crystal plane. SEM images of Zn^{2+} plating/stripping evolution after 24 h in (h) $\text{Zn}(\text{OTF})_2\text{-H}_2\text{O}$ and (i) $\text{Zn}(\text{OTF})_2\text{-NAF}$ electrolytes. TEM images of SEI thickness at 1 mA cm^{-2} in (j) $\text{Zn}(\text{OTF})_2\text{-H}_2\text{O}$ and (k) $\text{Zn}(\text{OTF})_2\text{-NAF}$ electrolytes.

coordination probability of OTF^- with Zn^{2+} in the $\text{Zn}(\text{OTF})_2\text{-NAF}$ electrolyte is significantly higher than that in the $\text{Zn}(\text{OTF})_2\text{-H}_2\text{O}$ electrolyte, triggering favorable solvated environments to limit the hydrogen evolution reaction of H_2O molecules, and boosting the Zn^{2+} plating/stripping efficiency at high current densities. The chemical components on the surface of the Zn anode were detected by Ar^+ sputtering X-ray photoelectron spectroscopy (XPS). To maintain the uniformity and integrity of the SEI, all cells were subjected to two constant-current (dis)charging cycles. The elemental contents of the SEI show significant differences for different electrolytes (

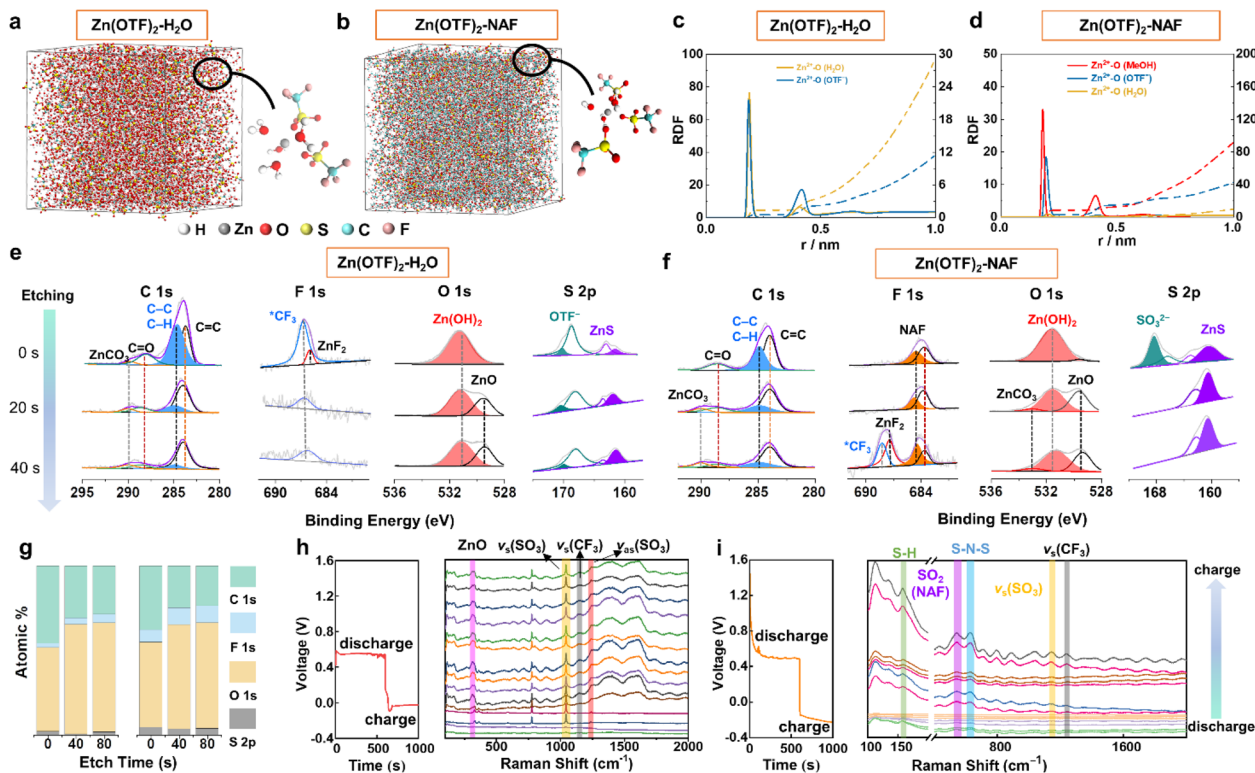


Fig. 2 (a and b) 3D snapshots and corresponding enlarged images of solvation sheaths, and (c and d) radial distribution functions of Zn²⁺-O in Zn(OTF)₂-H₂O and Zn(OTF)₂-NAF electrolytes. (e and f) In-depth XPS spectra analysis of different electrolytes. (g) The atomic concentration percentages corresponding to different SEIs. *In situ* Raman test of Zn||Cu cells in (h) Zn(OTF)₂-H₂O and (i) Zn(OTF)₂-NAF electrolytes.

ions in the Zn(OTF)₂-MeOH electrolyte damages the formed SEI and causes sustained

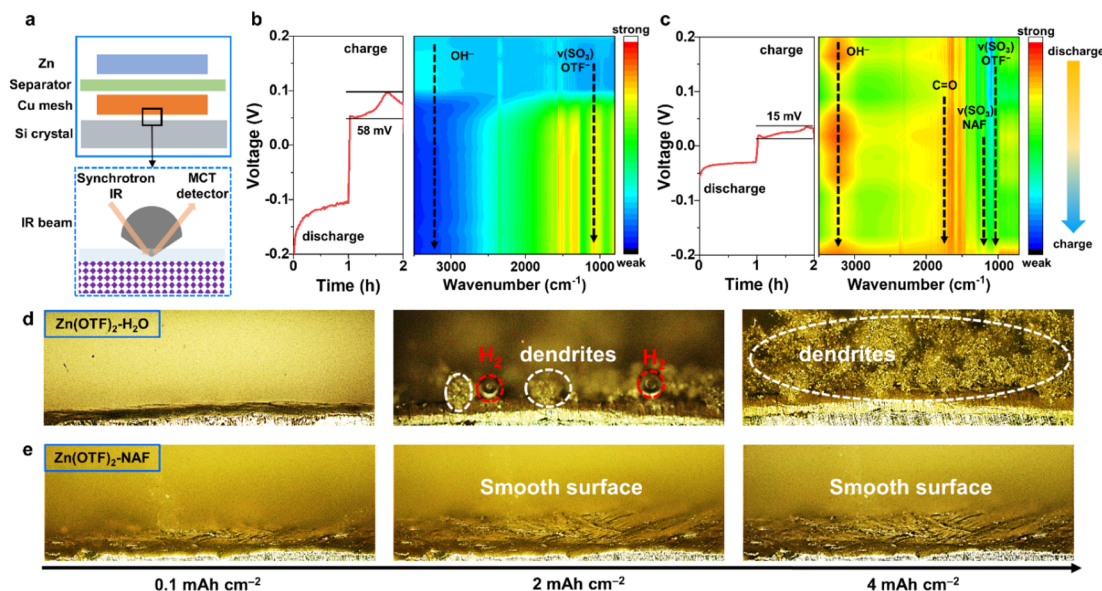


Fig. 3 (a) Schematic diagram of *in situ* ATR-FTIR analysis. (b and c) Voltage–time curves and corresponding ATR-FTIR characterizations in $\text{Zn}(\text{OTF})_2\text{-H}_2\text{O}$ and $\text{Zn}(\text{OTF})_2\text{-NAF}$ electrolytes. *In situ* DOF microscope plating images in (d) $\text{Zn}(\text{OTF})_2\text{-H}_2\text{O}$ and (e) $\text{Zn}(\text{OTF})_2\text{-NAF}$ electrolytes.

state in the solvation sheath of Zn^{2+} ions and shields it from H_2O molecules, which is crucial for rapid Zn^{2+} transport.^{60–62} The dendrite growth and hydrogen production on the Zn anode were directly observed through *in situ* depth of field (DOF) microscopy. For the $\text{Zn}(\text{OTF})_2\text{-H}_2\text{O}$ electrolyte, the generation of bubbles can be observed when the Zn^{2+} plating capacity reaches 0.1 mA h cm^{-2} (Fig. 3d). As the discharging process continues, obvious gray-black dendrites appear on the Zn anode, accompanied by severe corrosion after deposition (Fig. S21†). Due to the direct contact between the Zn anode and electrolyte, similar phenomena can also be examined in the $\text{Zn}(\text{OTF})_2\text{-MeOH}$ electrolyte (Fig. S22†). Without the regulation by the NAF-nanofilm, the Zn^{2+

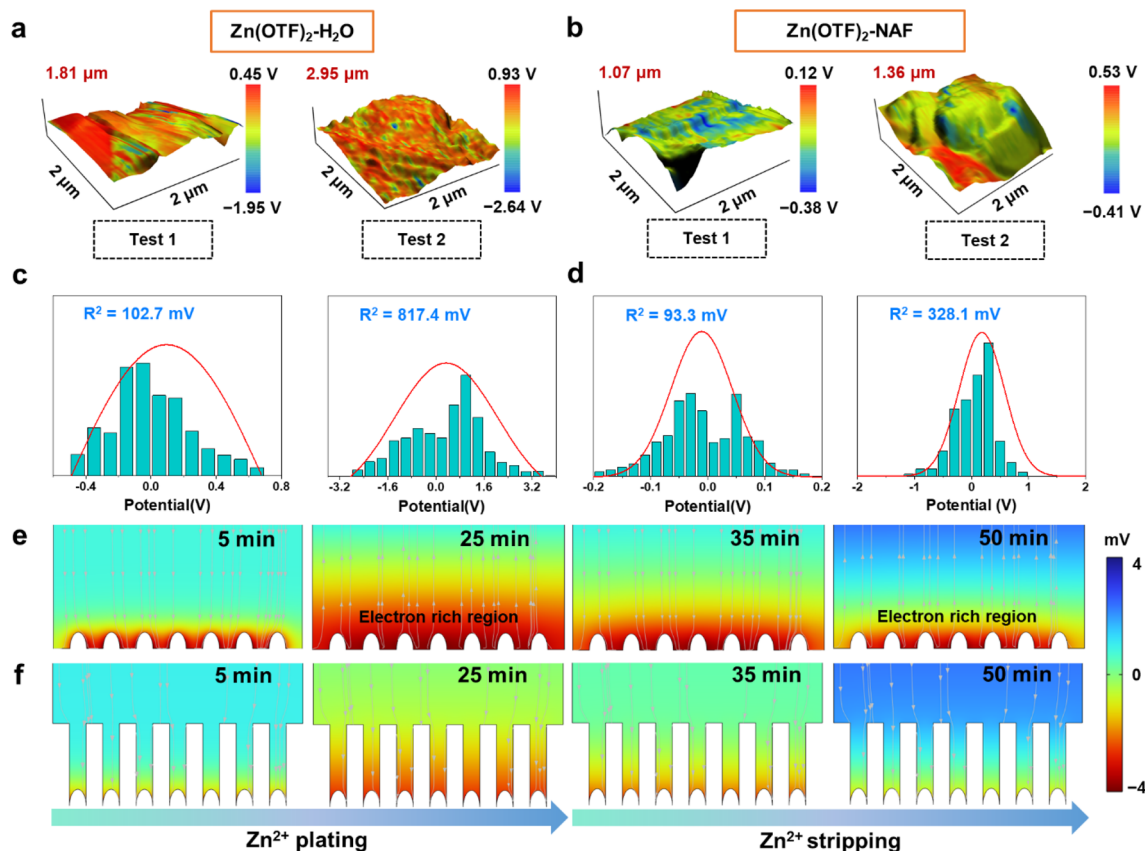


Fig. 4 (a and b) Potential distribution and height variation on the anode surface after Zn²⁺ plating in different electrolytes, tests 1 and 2 were Zn²⁺ plated to 1 and 2 mA h cm⁻², respectively (the current density was 0.5 mA cm⁻²). Gaussian statistical distribution of the interfacial potential in (c) Zn(OTF)₂-H₂O and (d) Zn(OTF)₂-NAF electrolytes. Simulation of the potential evolution of Zn²⁺ plating/stripping in (e) Zn/electrolyte and (f) Zn-NAF/electrolyte interfaces.

main reason for the slow Zn²⁺ plating/stripping. Based on the deposition potential analysis, the potential simulation of the Zn²⁺ plating/stripping process was performed through the COMSOL potential field.⁶⁶ During Zn²⁺ plating (from 5 to 25 min) in Zn(OTF)₂-H₂O electrolyte, a local micro-electric field is formed due to the polarization of the electrolyte concentration near the Zn anode (Fig. 4e), which exacerbates the hydrogen evolution reaction (HER) of solvation H₂O molecules and dendrite growth. The potential gradient near the Zn anode remains less than 0 mV during the stripping (35 to 50 min). In the Zn(OTF)₂-NAF electrolyte, a microporous film (NAF-nanofilm

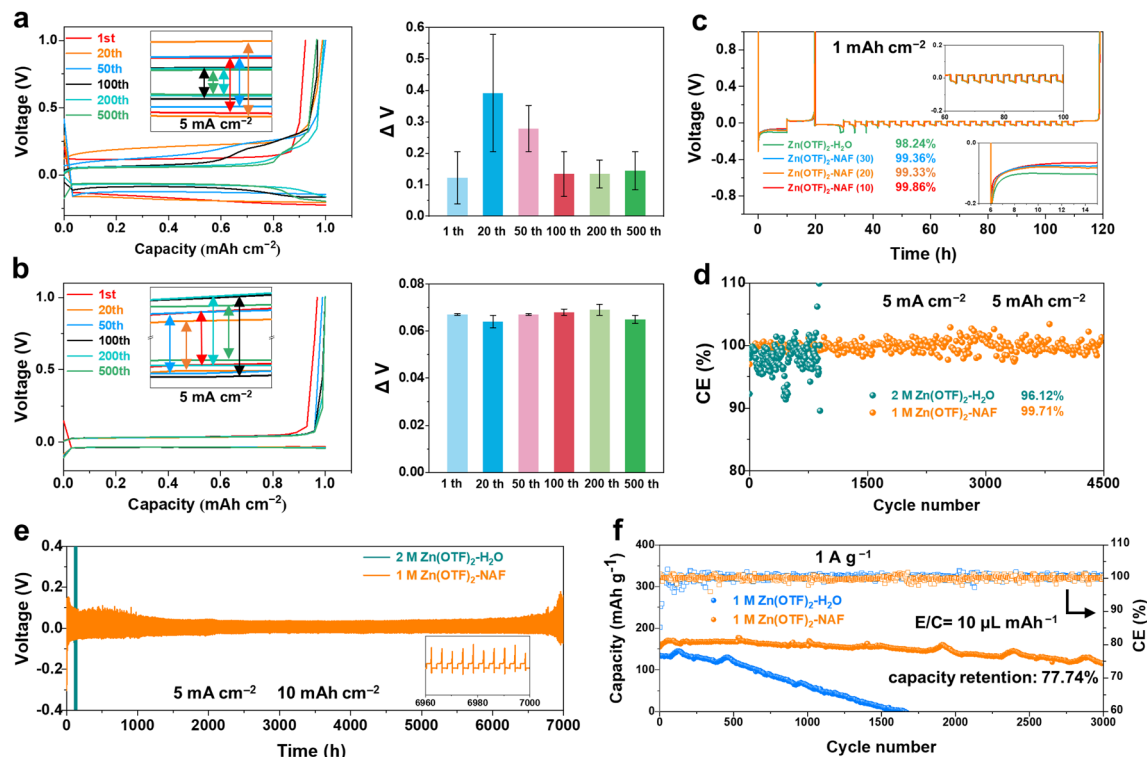


Fig. 5 Long-term deposition voltage–capacity curves and corresponding voltage fluctuation of Zn||Cu cells in (a) Zn(OTF)₂-H₂O and (b) Zn(OTF)₂-NAF electrolytes. (c) Zn||Cu cells with different electrolytes. (d) The plating/stripping CE of Zn||Cu cells. (e) Long-term performance of Zn||Zn cells. (f) Cycling performance of Zn||MnO₂ cells in different electrolytes at 30 °C.

efficiency in Zn²⁺ ion plating/deposition (Fig. S28†). For comparison, Zn||Cu cells using the Zn(OTF)₂-H₂O electrolyte show a CE of 96.12%. Despite the Zn²⁺ plating/stripping in the Zn(OTF)₂-MeOH electrolyte reaching 2700 h (while 280 h for the Zn(OTF)₂-H₂O electrolyte), the deposition overpotential of Zn²⁺ is continuously increased from 0.3 to 0.65 V. Benefiting from the regulation of Zn²⁺ transportation channels at the Zn anode, the NAF-nanofilm accelerates Zn²⁺ transport in the anode/electrolyte interface. Consequently, Zn||Zn cells using the Zn(OTF)₂-NAF electrolyte

Author contributions

The authors contributed to this work in the following ways: conceptualization (M. Liu, D. Zhang, Z. Song); data curation (D. Zhang); formal analysis (M. Liu, D. Zhang); funding acquisition (M. Liu, L. Gan, Y. Lv); investigation (M. Liu, D. Zhang, L. Miao); methodology (M. Liu, D. Zhang, Z. Song, L. Gan, L. Miao, Y. Lv); project administration (M. Liu); supervision (M. Liu); validation (M. Liu, L. Gan, Y. Lv); visualization (M. Liu, D. Zhang, L. Miao); writing – original draft (D. Zhang); writing – review & editing (M. Liu, D. Zhang, Z. Song).

Conflicts of interest

The authors declare no conflict of interest.

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